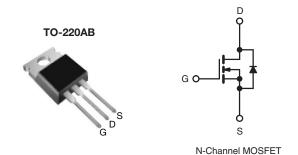


Power MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	50	500				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.28				
Q _g (Max.) (nC)	130	130				
Q _{gs} (nC)	33	33				
Q _{gd} (nC)	59					
Configuration	Single					



FEATURES

• Low Gate Charge Qq results in Simple Drive



• Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness

- Fully Characterized Capacitance and Avalanche Voltage and Current
- Low t_{rr} and Soft Diode Recovery
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply
- High Speed Power Switching
- ZVS and High Frequency Circuit
- PWM Inverters

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRFB17N50LPbF		
	SiHFB17N50L-E3		
SnPb	IRFB17N50L		
SILL	SiHFB17N50L		

ABSOLUTE MAXIMUM RATINGS (T_C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current	V -+ 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		16	А	
	V _{GS} at 10 V	T _C = 100 °C	I _D	11		
Pulsed Drain Current ^a			I _{DM}	64		
Linear Derating Factor				1.8	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	390	mJ	
Repetitive Avalanche Current ^a			I _{AR}	16	Α	
Repetitive Avalanche Energy ^a			E _{AR}	22	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	220	W	
Peak Diode Recovery dV/dt ^c			dV/dt	13	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		
Mounting Torque	6 22 or l	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		-	1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Starting T_J = 25 °C, L = 3.0 mH, R_g = 25 Ω , I_{AS} = 16 A (see fig. 12).
- c. $I_{SD} \leq 16~A$, $dI/dt \leq 347~A/\mu s, V_{DD} \leq V_{DS}, T_J \leq 150~^{\circ}C.$
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFB17N50L, SiHFB17N50L

Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.56			

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.6	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		3.0	-	5.0	V	
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 30 V		-	-	± 100	nA	
Zana Oata Valta aa Dusin Ouwant		V _{DS} = 500 V, V _{GS} = 0 V		-	-	50	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 400 \	/, V _{GS} = 0 V, T _J = 125 °C	-	-	2.0	mA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 9.9 A ^b	-	0.28	0.32	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 9.9 A ^b	11	-	-	S	
Dynamic								
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	2760	-		
Output Capacitance	C _{oss}]	$V_{DS} = 25 \text{ V},$	-	325	-		
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	37	-	,r	
Outro d Connectors	0	$V_{GS} = 0 V$	V _{DS} = 1.0 V , f = 1.0 MHz	-	3690	-	pF	
Output Capacitance	C_{oss}	V _{GS} = 0 V	V _{DS} = 400 V , f = 1.0 MHz	-	84	-	•	
Effective Output Capacitance	Coss eff.	V _{GS} = 0 V	V _{DS} = 0 V to 400 V ^c	-	159	-		
Total Gate Charge	Qg			-	-	130	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 16 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b		-	33		
Gate-Drain Charge	Q_{gd}	1	goo ng. o ana .o	-	-	59		
Turn-On Delay Time	t _{d(on)}		V_{DD} = 250 V, I_D = 16 A, R_g = 7.5 Ω , see fig. 10 ^b		21	-	- ns	
Rise Time	t _r	V _{DD} =			51	-		
Turn-Off Delay Time	t _{d(off)}	$R_g =$			50	-		
Fall Time	t _f	1	1			-	1	
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I _S	MOSFET sym	ibol	-	-	16		
Pulsed Diode Forward Current ^a	I _{SM}	showing the integral reverse p - n junction diode		-	-	64	А	
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 16 A, V _{GS} = 0 V ^b		-	-	1.5	V	
	t _{rr}	T _J = 25 °C		-	170	250	ns	
Body Diode Reverse Recovery Time				-	220	330		
Body Diode Reverse Recovery Charge	Q _{rr}	T _J = 25 °C	I _E = 16 A, dl/dt = 100 A/us ^b		470	710		
		T _J = 125 °C	1	-	810	1210	nC	
Reverse Recovery Current	I _{RRM}		1	-	7.3	11	Α	
Forward Turn-On Time	t _{on}	Intrinsic to	ırn-on time is negligible (turn-	on is dor	ninated b	v Le and	[[[]]	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width $\leq 300 \,\mu s$; duty cycle $\leq 2 \,\%$.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

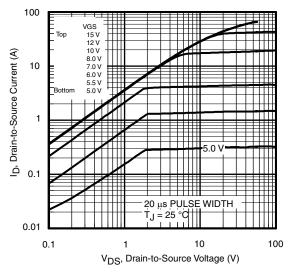


Fig. 1 - Typical Output Characteristics

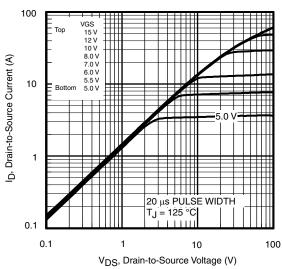


Fig. 2 - Typical Output Characteristics

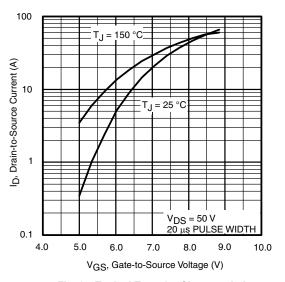


Fig. 3 - Typical Transfer Characteristics

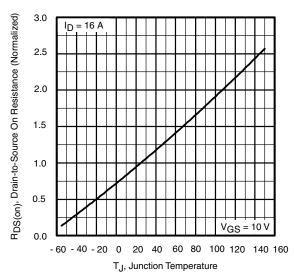


Fig. 4 - Normalized On-Resistance vs. Temperature



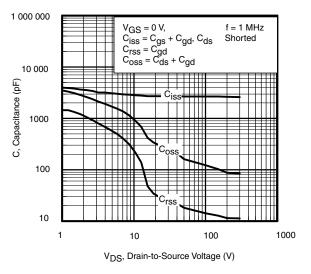


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

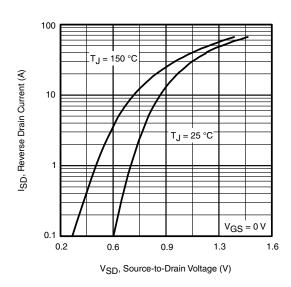


Fig. 7 - Typical Source-Drain Diode Forward Voltage

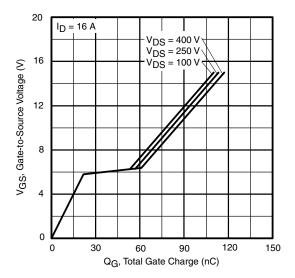


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

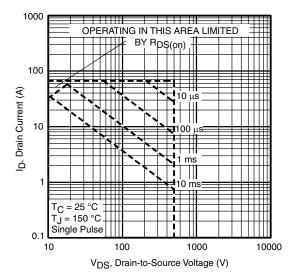


Fig. 8 - Maximum Safe Operating Area

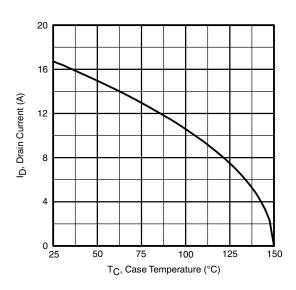


Fig. 9 - Maximum Drain Current vs. Case Temperature

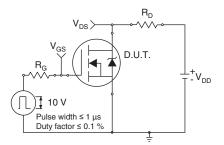


Fig. 10a - Switching Time Test Circuit

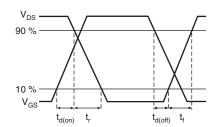


Fig. 10b - Switching Time Waveforms

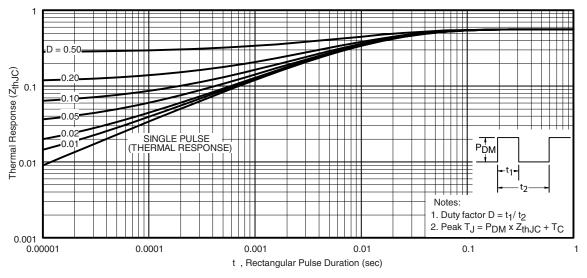


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



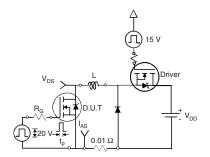


Fig. 12a - Unclamped Inductive Test Circuit

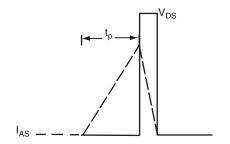


Fig. 12b - Unclamped Inductive Waveforms

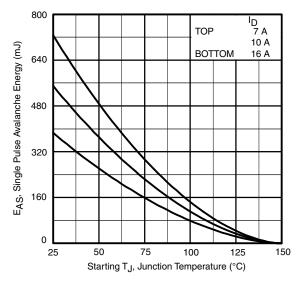


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

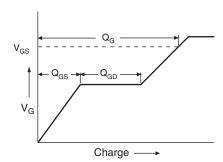


Fig. 13a - Basic Gate Charge Waveform

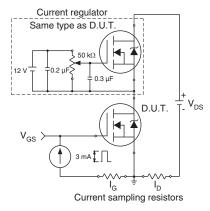
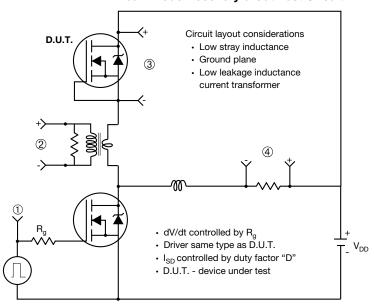


Fig. 13b - Gate Charge Test Circuit

Peak Diode Recovery dV/dt Test Circuit



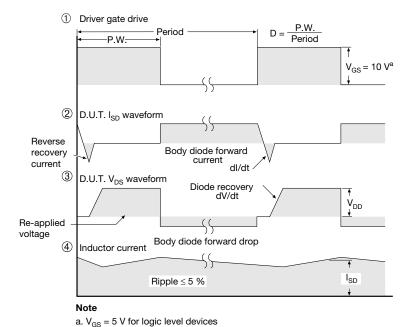


Fig. 14 - For N-Channel

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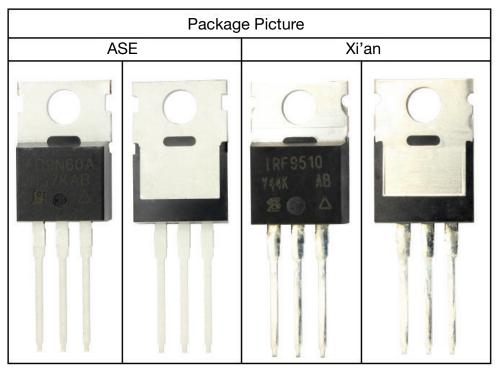
TO-220-1



DIM	MILLIN	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
E	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 \bullet $M^{\star}=0.052$ inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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